

FQD5N40 / FQU5N40 N-Channel QFET® MOSFET 400 V, 3.4 A, 1.6 Ω

July 2013

Description

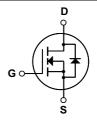
This N-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts.

Features

- 3.4 A, 400 V, $R_{DS(on)}$ =1.6 $\Omega(Max.)$ @ V_{GS} =10 V, I_D =1.7 A
- Low Gate Charge (Typ. 10 nC)
- Low C_{rss} (Typ. 7 pF)
- · 100% Avalanche Tested







Absolute Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter		FQD5N40 / FQU5N40	Unit
V _{DSS}	Drain-Source Voltage		400	V
I _D	Drain Current - Continuous (T _C = 25°C)		3.4	Α
	- Continuous (T _C = 100°C)		2.15	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	13.6	Α
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	290	mJ
I _{AR}	Avalanche Current	(Note 1)	3.4	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	4.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P _D	Power Dissipation (T _A = 25°C) * Power Dissipation (T _C = 25°C) - Derate above 25°C		2.5	W
			45	W
			0.36	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

Thermal Characteristics

Symbol	Parameter	FQD5N40 / FQU5N40	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	2.78	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient * , Max.	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient , Max.	110	°C/W

^{*} When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	400			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	;	0.38		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 400 V, V _{GS} = 0 V			1	μΑ
		V _{DS} = 320 V, T _C = 125°C			10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V			100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30 V, V _{DS} = 0 V			-100	nA
On Cha	aracteristics		•			
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 1.7 A		1.27	1.6	Ω
9 _{FS}	Forward Transconductance	V _{DS} = 50 V, I _D = 1.7 A		2.9		S
C _{oss}	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		60 7	80 9	pF pF
C _{rss}	Reverse Transfer Capacitance			7	9	pF
Switch	ing Characteristics					
$t_{d(on)}$	Turn-On Delay Time	V _{DD} = 200 V, I _D = 4.5 A,		12	30	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		60	130	ns
t _{d(off)}	Turn-Off Delay Time	- 1.6 - 1 - 1		20	50	ns
t _f	Turn-Off Fall Time	(Note	+)	30	70	ns
Qg	Total Gate Charge	V _{DS} = 320 V, I _D = 4C5 A,		10	13	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		3.0		nC
Q _{gd}	Gate-Drain Charge	(Note 4		4.5		nC
⊶gd						
	Source Diode Characteristics a	nd Maximum Ratings				
Drain-S	Source Diode Characteristics at Maximum Continuous Drain-Source Dio				3.4	Α
Drain-S		ode Forward Current			3.4 13.6	A
Drain-S	Maximum Continuous Drain-Source Did	ode Forward Current				
Drain-S I _S	Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	ode Forward Current Forward Current			13.6	Α

- Notes: 1. Repetitive Rating: Pulse width limited by maximum junction temperature 2. L = 44 mH, I_{AS} = 3.4 A, V_{DD} \leq 50 V, R_G = 25 Ohm, Starting T_J = 25°C 3. I_{SD} \leq 4.5A, di/dt \leq 200 A/us, V_{DD} \leq BVDSS, Starting T_J = 25°C 4. Essentially independent of operating temperature

Typical Characteristics

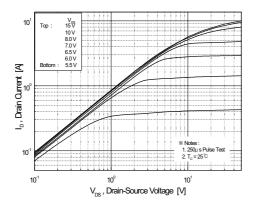


Figure 1. On-Region Characteristics

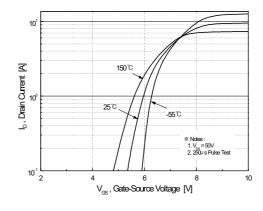


Figure 2. Transfer Characteristics

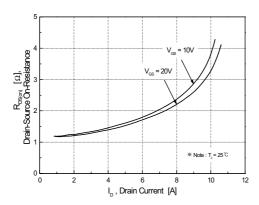


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

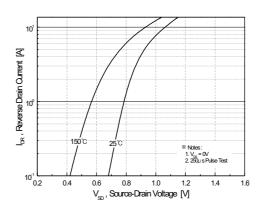


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

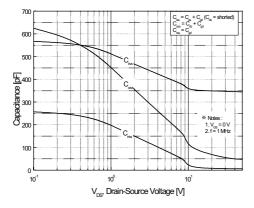


Figure 5. Capacitance Characteristics

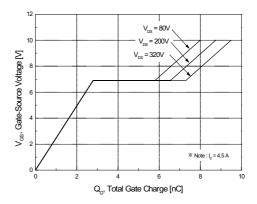


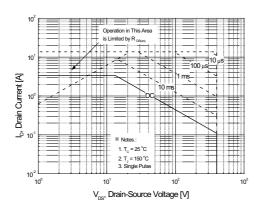
Figure 6. Gate Charge Characteristics

1.2 (bozinum), 381 (bozinum)

Typical Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



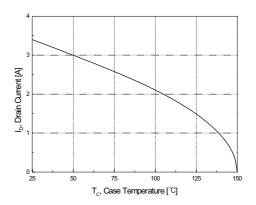


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

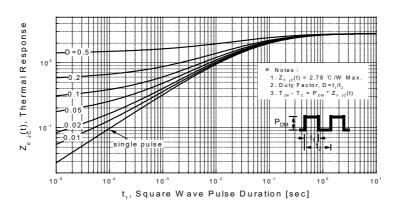
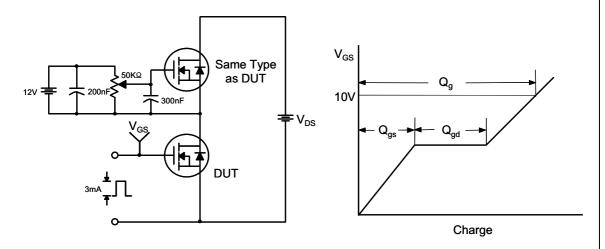
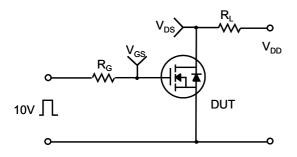


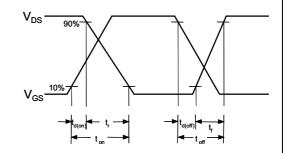
Figure 11. Transient Thermal Response Curve

Gate Charge Test Circuit & Waveform

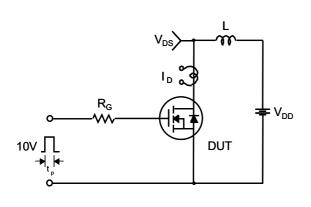


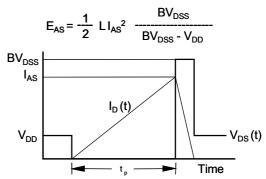
Resistive Switching Test Circuit & Waveforms



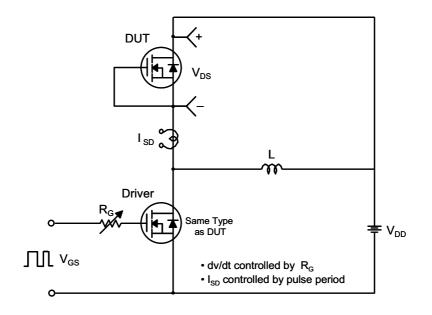


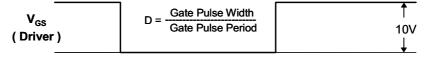
Unclamped Inductive Switching Test Circuit & Waveforms

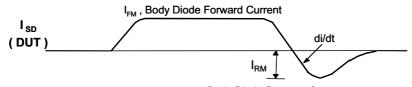




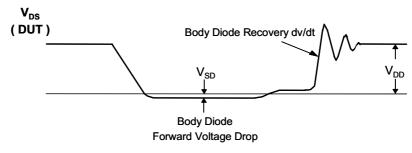
Peak Diode Recovery dv/dt Test Circuit & Waveforms







Body Diode Reverse Current



Package Dimensions DPAK 6.00 MIN -6.50 MIN -1.02 MAX C Ī 21 3 (0.59)1.40 MIN 2.30 2.29 ⊕ 0.25**M** A**M** C - 4.60 4.57 LAND PATTERN RECOMMENDATION SEE 4.32 MIN NOTE D 5.21 MIN SEE 10.41 9.40 DETAIL A △ 0.10 B NOTES: UNLESS OTHERWISE SPECIFIED A) THIS PACKAGE CONFORMS TO JEDEC, TO-252, ISSUE C, VARIATION AA. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994. D) HEAT SINK TOP EDGE COULD BE IN CHAMFERED CORNERS OR EDGE PROTRUSION. E) PRESENCE OF TRIMMED CENTER LEAD IS OPTIONAL. F) DIMENSIONS ARE EXCLUSSIVE OF BURSS. 0.51 GAGE PLANE 0.61 1.78 1.40 0.127 MAX DIMENSIONS ARE EXCLUSSIVE OF BURSS, MOLD FLASH AND TIE BAR EXTRUSIONS. LAND PATTERN RECOMENDATION IS BASED ON IPC7351A STD T0220P1003X238-3N. F) SEATING PLANE (2.90)G) DETAIL A (ROTATED -90°) SCALE: 12X DRAWING NUMBER AND REVISION: MKT-T0252A03REV8

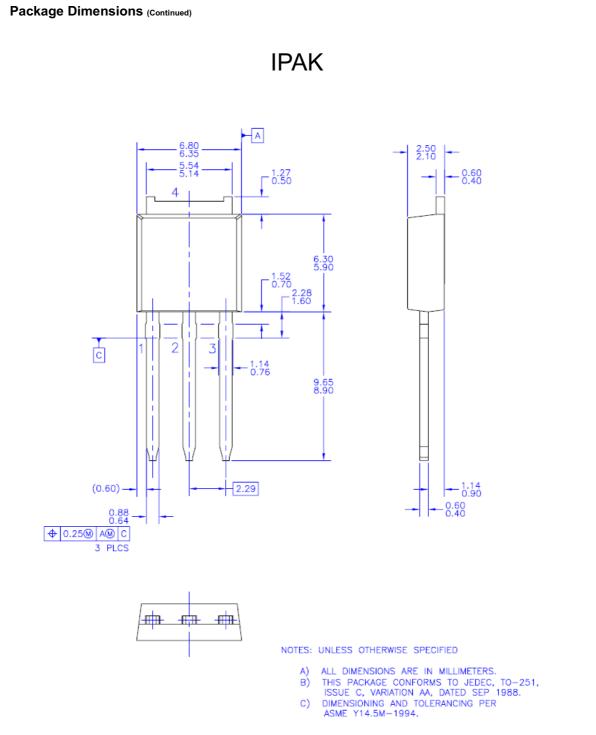
TO-252 (DPAK) MOLDED, 3 LEAD, OPTION AA

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Dimensions in Millimeters



TO-251 (IPAK) MOLDED, 3LEAD, OPTION AA

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Dimensions in Millimeters





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